



US009175393B1

(12) **United States Patent**
Higashi et al.

(10) **Patent No.:** **US 9,175,393 B1**
(45) **Date of Patent:** **Nov. 3, 2015**

(54) **TILED SHOWERHEAD FOR A
SEMICONDUCTOR CHEMICAL VAPOR
DEPOSITION REACTOR**

(75) Inventors: **Gregg Higashi**, San Jose, CA (US);
Khurshed Sorabji, San Jose, CA (US);
Lori D. Washington, Union City, CA
(US); **Andreas Hegedus**, Burlingame,
CA (US)

(73) Assignee: **Alta Devices, Inc.**, Sunnyvale, CA (US)

(*) Notice: Subject to any disclaimer, the term of this
patent is extended or adjusted under 35
U.S.C. 154(b) by 444 days.

5,304,247 A *	4/1994	Kondo et al.	118/715
5,304,398 A	4/1994	Krusell et al.	
5,532,190 A *	7/1996	Goodyear et al.	438/710
5,792,272 A	8/1998	Van Os et al.	
6,001,267 A	12/1999	Os et al.	
6,113,700 A	9/2000	Choi	
6,821,910 B2 *	11/2004	Adomaitis et al.	438/758
6,852,167 B2 *	2/2005	Ahn	118/715
7,104,476 B2 *	9/2006	Kim	239/557
7,410,668 B2 *	8/2008	Ahn	427/248.1
7,429,410 B2 *	9/2008	Keller et al.	427/578
7,484,473 B2 *	2/2009	Keller et al.	118/723 R
7,537,662 B2 *	5/2009	Soininen et al.	118/715
7,601,223 B2 *	10/2009	Lindfors et al.	118/715
7,718,030 B2 *	5/2010	Funk et al.	156/345.29

(Continued)

OTHER PUBLICATIONS

(21) Appl. No.: **13/222,890**

(22) Filed: **Aug. 31, 2011**

(51) Int. Cl.

C23C 16/50	(2006.01)
H01L 21/306	(2006.01)
C23F 1/00	(2006.01)
C23C 16/455	(2006.01)
C23C 16/458	(2006.01)

(52) U.S. Cl.

CPC **C23C 16/45565** (2013.01); **C23C 16/455**
(2013.01); **C23C 16/4582** (2013.01); **C23C**
16/4583 (2013.01); **C23C 16/45563** (2013.01)

(58) Field of Classification Search

CPC **C23C 16/455**; **C23C 16/45563**; **C23C**
16/45565; **C23C 16/4582**; **C23C 16/4583**
USPC **118/715**, **728**; **156/345.33**, **345.34**,
156/345.51

See application file for complete search history.

(56) References Cited

U.S. PATENT DOCUMENTS

4,993,358 A *	2/1991	Mahawili	118/715
5,059,770 A	10/1991	Mahawili	
5,122,391 A *	6/1992	Mayer	427/126.3

Book: D.M. Dobkin et al., Principles of Chemical Vapor Deposition,
2003 Kluwer Academic Publishers, Chapter 3, 3 pages.

Primary Examiner — Rudy Zervigon

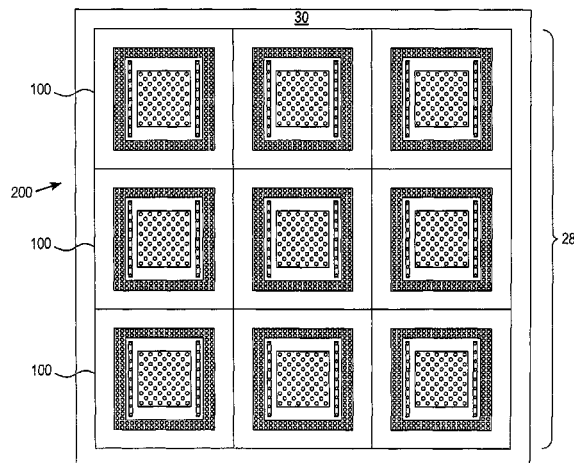
(74) Attorney, Agent, or Firm — Thomas Schneck; Gina
McCarthy

(57)

ABSTRACT

A showerhead for a semiconductor-processing reactor formed by an array of showerhead tiles. Each showerhead tile has a plurality of process gas apertures, which may be in a central area of the tile or may extend over the entire tile. Each showerhead tile can be dimensioned for processing a respective substrate or the array can be dimensioned for processing a substrate. An exhaust region surrounds the process gas apertures. The exhaust region has at least one exhaust aperture, and may include an exhaust slot, a plurality of connected exhaust slots or a plurality of exhaust apertures. The exhaust region surrounds the array of showerhead tiles, or a respective portion of the exhaust region surrounds the plurality of process gas apertures in each showerhead tile or group of showerhead tiles. A gas curtain aperture may be between the exhaust region and the process gas apertures of one of the showerhead tiles or adjacent to the central area of the tile.

21 Claims, 6 Drawing Sheets



(56)

References Cited

U.S. PATENT DOCUMENTS

7,789,961	B2 *	9/2010	Nelson et al.	118/715	2006/0060138	A1 *	3/2006	Keller et al.	118/715
7,794,546	B2 *	9/2010	Li	118/733	2006/0234514	A1 *	10/2006	Gianoulakis et al.	438/758
8,008,174	B2	8/2011	He et al.		2007/0068625	A1 *	3/2007	Funk et al.	156/345.29
8,038,834	B2 *	10/2011	Funk et al.	156/345.29	2007/0092732	A1	4/2007	Rose et al.	
8,075,690	B2 *	12/2011	Keller et al.	118/715	2007/0107661	A1 *	5/2007	Ahn	118/719
8,143,074	B2 *	3/2012	Day et al.	438/5	2007/0131169	A1 *	6/2007	Ahn	118/715
8,236,106	B2 *	8/2012	Iizuka et al.	118/715	2008/0000497	A1 *	1/2008	Verhaverbeke	134/1.1
8,277,888	B2 *	10/2012	Dedontney	427/248.1	2008/0124463	A1 *	5/2008	Bour et al.	427/255.28
8,293,013	B2 *	10/2012	DeDontney	118/715	2008/0196666	A1	8/2008	Toshima	
8,298,338	B2 *	10/2012	Kim et al.	118/715	2009/0061083	A1 *	3/2009	Chiang et al.	427/248.1
8,334,015	B2 *	12/2012	Chiang et al.	427/248.1	2009/0061644	A1 *	3/2009	Chiang et al.	438/763
8,366,828	B2 *	2/2013	Iizuka	118/715	2009/0061646	A1 *	3/2009	Chiang et al.	438/763
8,398,770	B2 *	3/2013	Levy et al.	118/718	2009/0229754	A1 *	9/2009	Iizuka et al.	156/345.34
8,402,845	B2 *	3/2013	Dedontney	73/865.9	2009/0236041	A1 *	9/2009	Iizuka	156/345.34
8,409,354	B2 *	4/2013	Chiang et al.	118/719	2009/0236447	A1	9/2009	Panagopoulos et al.	
8,440,259	B2 *	5/2013	Chiang et al.	427/248.1	2009/0324379	A1	12/2009	He et al.	
8,551,890	B2 *	10/2013	Goodlin et al.	438/758	2009/0325367	A1	12/2009	He et al.	
8,726,838	B2 *	5/2014	Shanker et al.	118/723 E	2010/0092668	A1	4/2010	Hegedus	
2002/0122885	A1 *	9/2002	Ahn	427/255.28	2010/0147370	A1	6/2010	He et al.	
2003/0207032	A1 *	11/2003	Ahn et al.	427/255.34	2010/0193471	A1 *	8/2010	Funk et al.	216/67
2005/0087134	A1 *	4/2005	Ahn	118/715	2010/0219509	A1	9/2010	He et al.	
2005/0092248	A1 *	5/2005	Lee et al.	118/715	2010/0233879	A1	9/2010	Ryan	
2005/0255257	A1 *	11/2005	Choi et al.	427/585	2010/0300359	A1 *	12/2010	Armour et al.	118/724
2006/0005771	A1 *	1/2006	White et al.	118/728	2011/0132542	A1 *	6/2011	Iizuka	156/345.33
					2011/0214812	A1 *	9/2011	Song et al.	156/345.33
					2011/0214814	A1 *	9/2011	Iizuka et al.	156/345.34

* cited by examiner

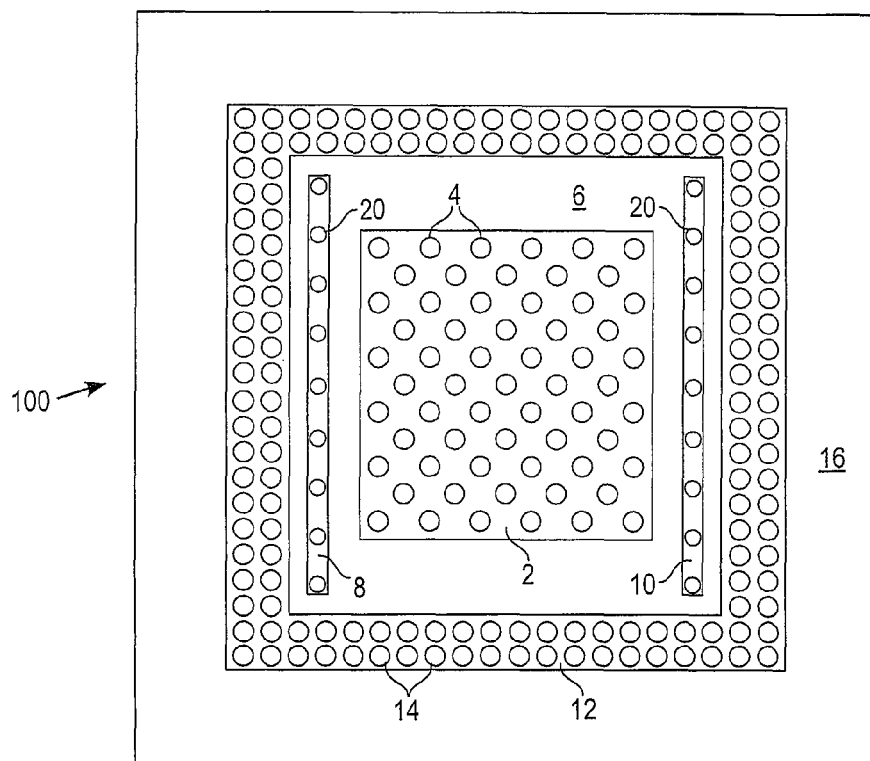


Fig. 1

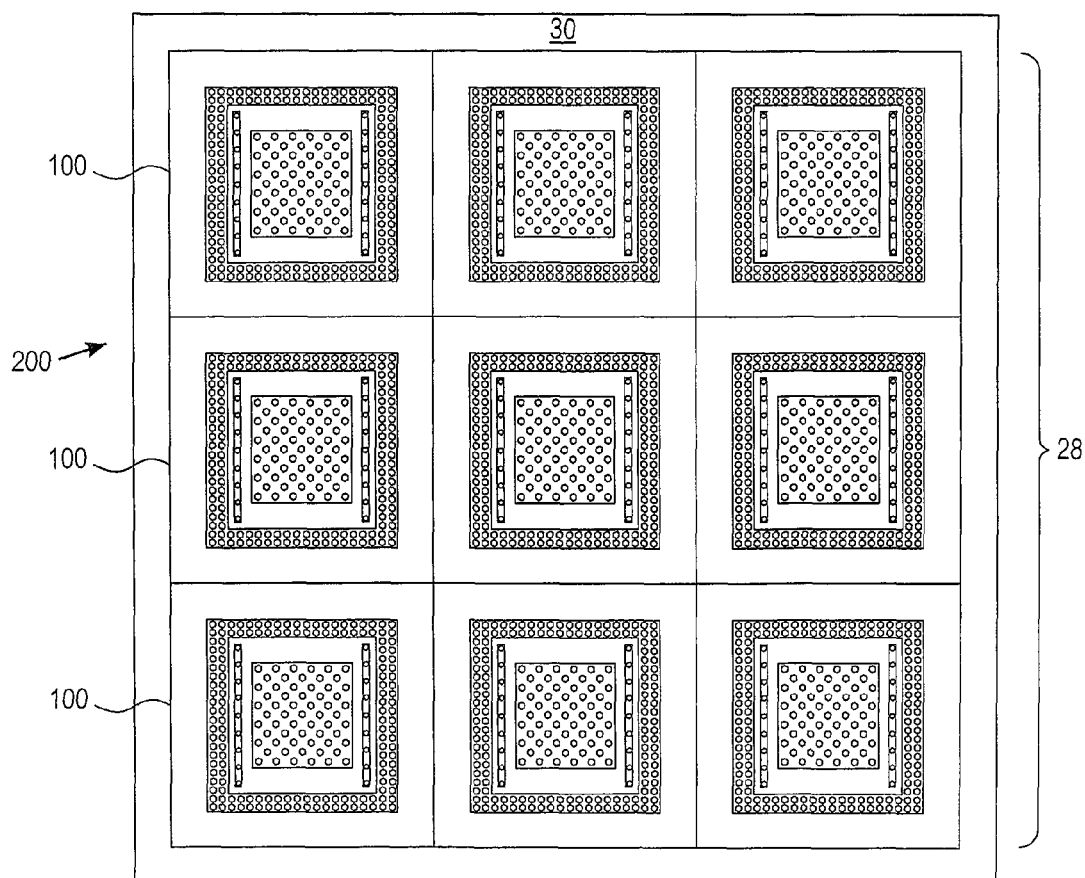
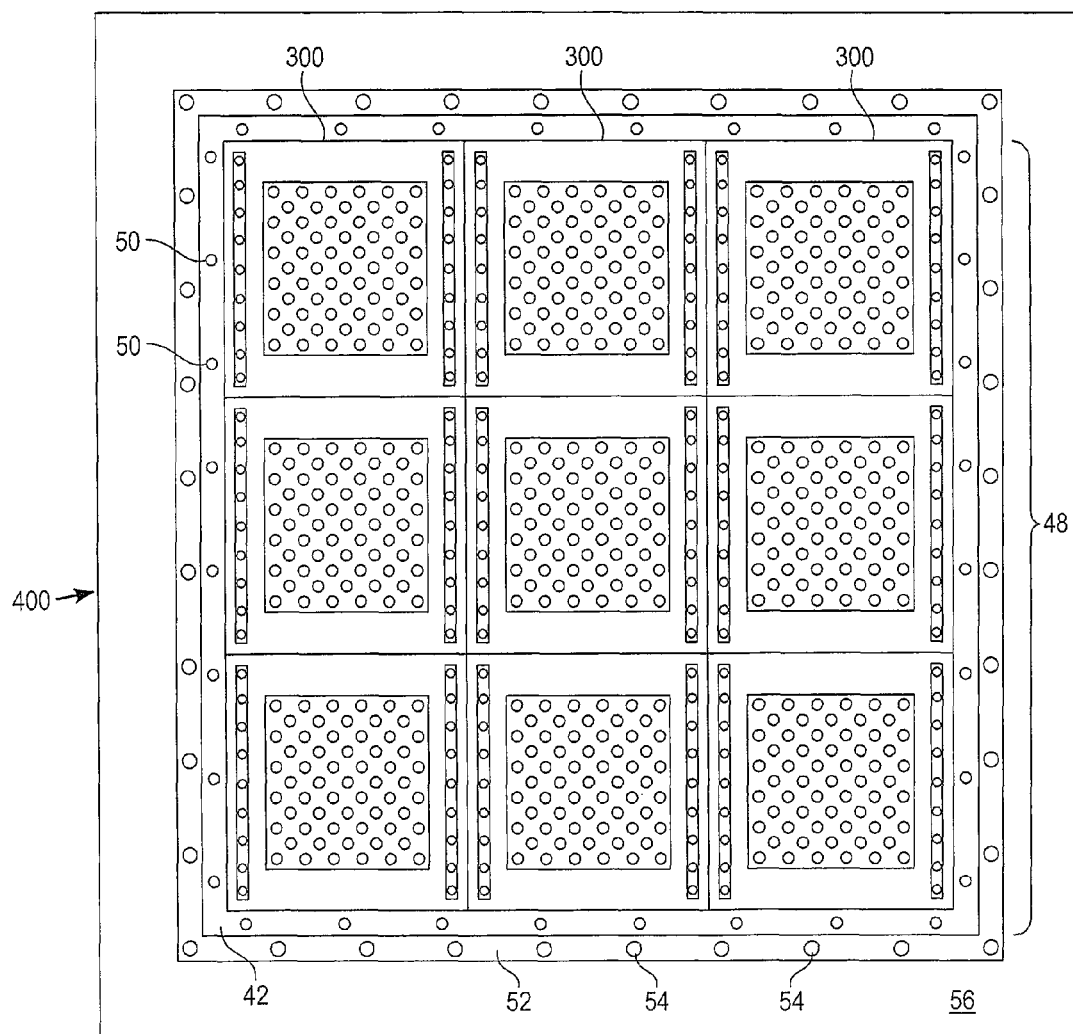
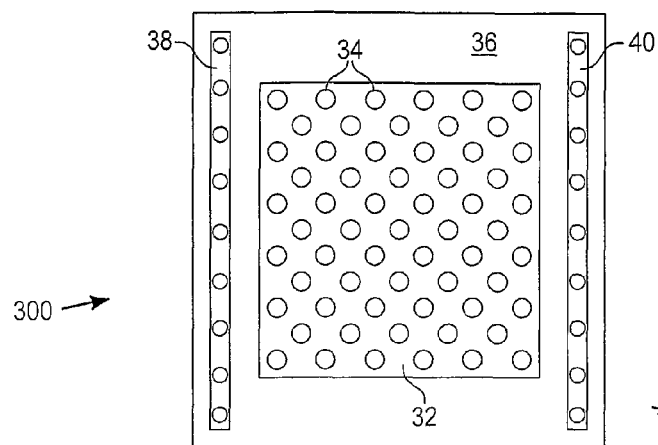


Fig. 2



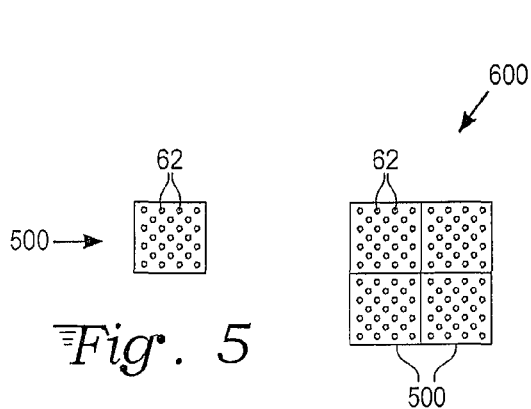


Fig. 5

Fig. 6

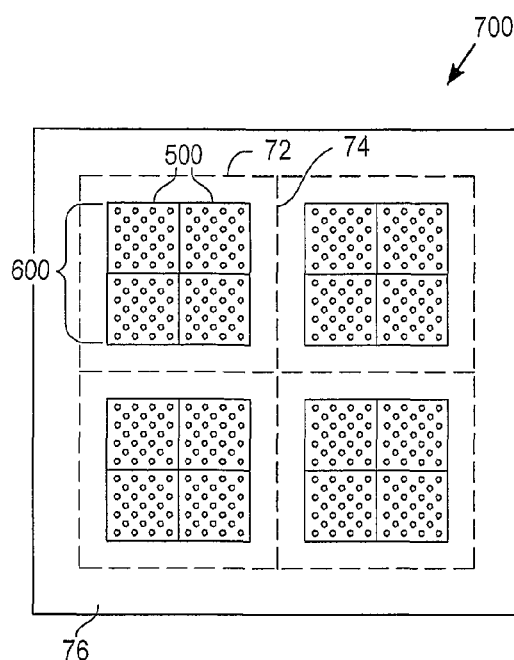


Fig. 7

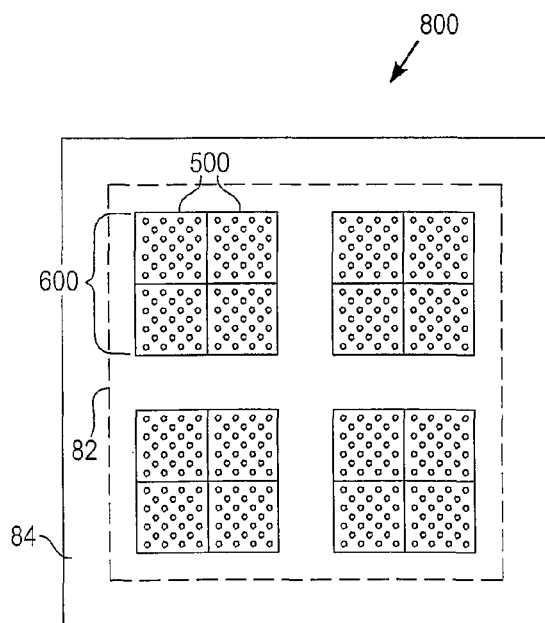


Fig. 8

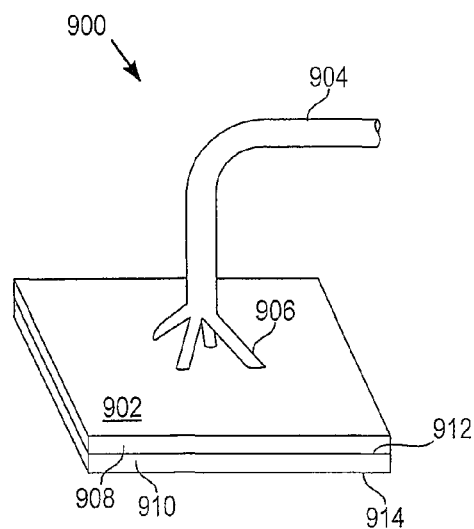


Fig. 9

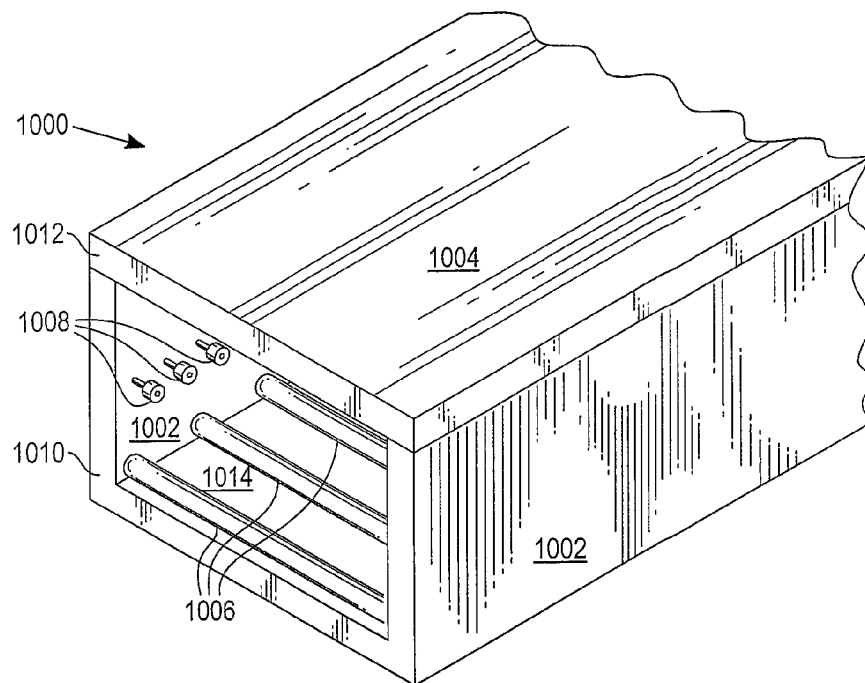


Fig. 10

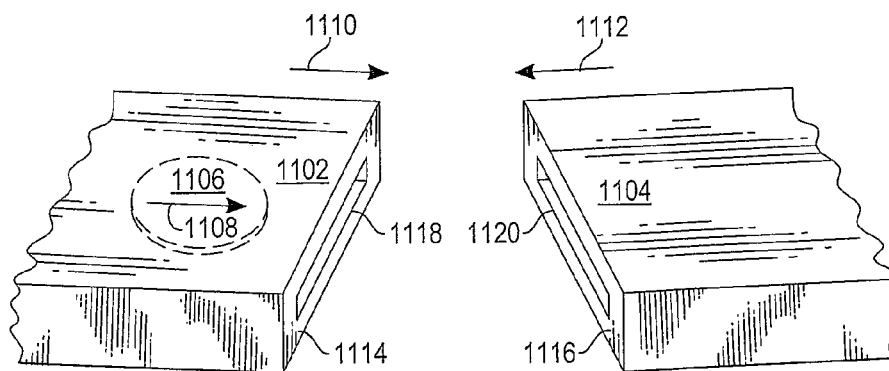


Fig. 11

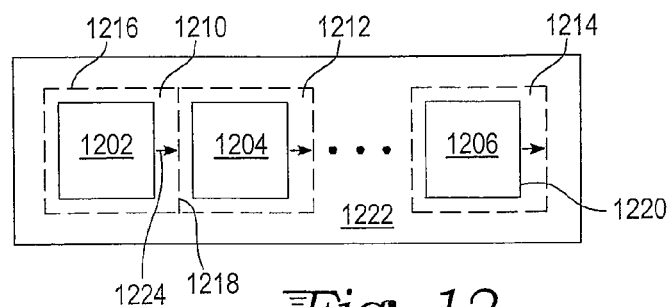


Fig. 12

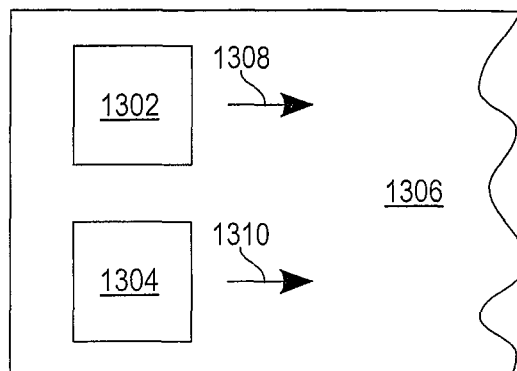


Fig. 13

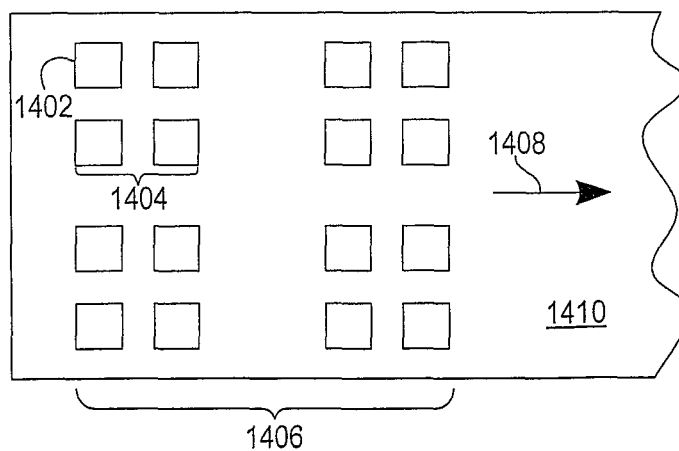


Fig. 14

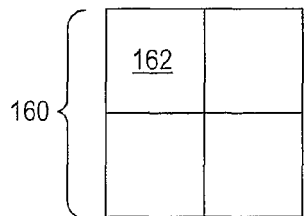


Fig. 15A

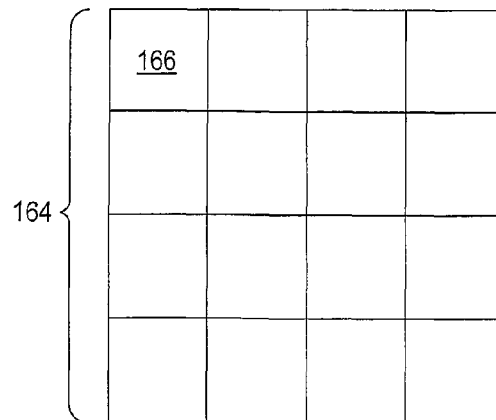


Fig. 15B

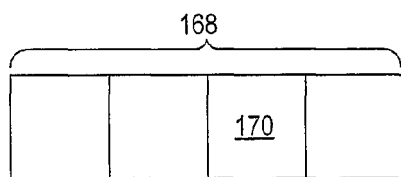


Fig. 15C

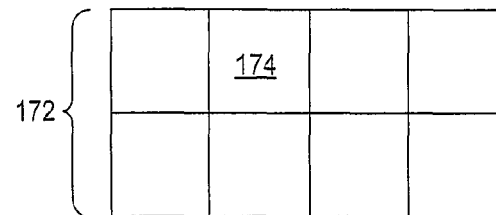


Fig. 15D

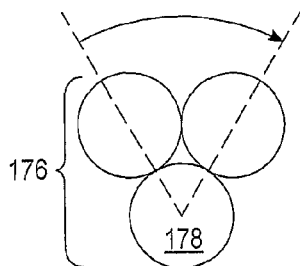


Fig. 15E

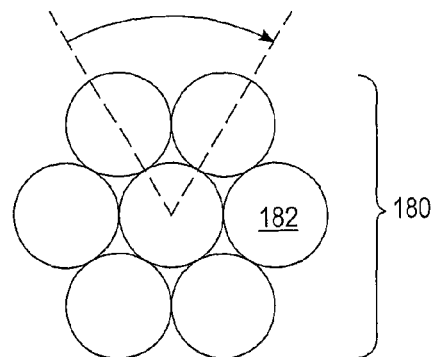


Fig. 15F

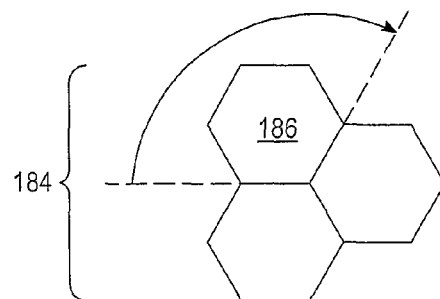


Fig. 15G

1

TILED SHOWERHEAD FOR A SEMICONDUCTOR CHEMICAL VAPOR DEPOSITION REACTOR

TECHNICAL FIELD

The field of the present disclosure relates to semiconductor processing and showerhead reactors, particularly to showerheads for chemical vapor deposition reactors.

BACKGROUND

Various deposition and etching processes and tools are used in semiconductor wafer processing such as for integrated circuits, solar photovoltaic cells and micro-machining. Two predominant types of reactors used in semiconductor processing are the tube-type reactor and the showerhead-type reactor, which are discussed in "Principles of Chemical Vapor Deposition" by Daniel M. Dobkin and Michael K. Zuraw, 2003, Kluwer Academic Publishers.

Typically, a chemical vapor deposition (CVD) showerhead reactor operates on a single wafer per chamber and thus has much lower wafer throughput than a CVD tube reactor, which handles many wafers in parallel in a single load. In a showerhead reactor, gases are distributed to a wafer from a showerhead (alternately, shower head). In a tube reactor, gases are distributed to a parallel-spaced set of wafers in a boat, with the gases traveling from an inlet at one end of the tube to an exhaust at the other end of the tube. Showerhead reactors are often run at a higher deposition rate in order to improve throughput for commercial viability.

Tube reactors and showerhead reactors are often known as hot-wall and cold-wall reactor designs respectively, with the tube reactor normally operated as nearly isothermal and the showerhead reactor having large temperature gradients from one part of the reactor to another. Generally, for plasma generation, showerhead reactors are preferred as compared to tube reactors, as tube-type plasma reactors have difficulties in mechanical design, particle control, electrical design and wafer handling. Tube reactors are suitable for processes requiring good temperature uniformity and high temperatures, such as polysilicon deposition. Showerhead reactors are suitable for lower temperature plasma-based processes including deposition of various materials and etching.

Plasma reactors often use a metallic showerhead as one plasma electrode, and a wafer in electrical connection with a chuck as the other plasma electrode. Walls of the chamber in which the showerhead and the wafer are mounted are generally held at ground potential for safety reasons. Electrons in the plasma lose energy to the chamber walls upon collision with the walls. Plasma enhanced chemical vapor deposition (PECVD) is often preferred in semiconductor processing as compared to physical vapor deposition (PVD), as films deposited by PECVD conformally cover processed wafer topographies, filling trenches or holes, and have superior electrical properties and lower defect densities.

Plenum dimensions and diameter, angle, and placement of holes in the showerhead affect flow of process gases. Generally, the showerhead has a diameter that is approximately the same as or is slightly larger than the silicon wafer or substrate being processed, as does the chuck supporting the wafer or substrate. Multiple gas plenums may be arranged in circumferential rings in or above the showerhead, for dispensing multiple gases without mixing in the plenum.

US Patent Application Publication No. 2010/0233879 A1 discloses a single-wafer, multiple-showerhead, multiple-chuck reactor. A wafer is moved to four or five different

2

chucks for deposition of a portion of a film at each chuck. Each showerhead introduces its own random nonuniformities. Using several chucks averages out the random nonuniformities.

Improvements in showerhead reactors are sought. It is a goal of the present invention to improve processing throughput in showerhead reactors.

SUMMARY

A goal of improving processing throughput in showerhead reactors is met with a tiled showerhead for a semiconductor-processing showerhead reactor. A showerhead "tile" is a showerhead with an array of gas outflow apertures. A showerhead tile can be about the same size as, or larger than or smaller than a standard showerhead. A tiled showerhead can be built up to a size that is larger than a standard showerhead. Some tiles can include exhaust ports and/or fluid temperature control, while other tiles rely on surrounding infrastructure for exhaust and/or fluid temperature control. Showerhead tiles enable a tiled showerhead to be scaled upwards or downwards by adding or subtracting repeated copies of a showerhead tile in a modular manner.

A tiled showerhead has an array of showerhead tiles that fit together in a defined area. Each of the showerhead tiles has a plurality of process gas apertures. Each tile can be dimensioned for processing a respective substrate or the entire array can be dimensioned for processing an areawise substrate. The tiled showerhead can be used for simultaneous processing of semiconductor wafers or similar substrates.

In one embodiment, each showerhead tile has fluid passageways adjacent to the central area of the tile. The fluid passageways may include cooling plenums, or exhaust gas passageways connected to gas curtain apertures. Sometimes an exhaust region, with an exhaust aperture, surrounds the central area of the showerhead tile.

In a further embodiment, each showerhead tile has at least one fluid passageway adjacent to the central area of the tile. The fluid passageway may include cooling plenums, or gas passageways connected to gas curtain apertures for reactive gas deposition on a substrate of corresponding size.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 is a top plan view of an exemplary showerhead tile in accordance with the present invention.

FIG. 2 is a top plan view of a tiled showerhead formed by an array of the showerhead tiles of FIG. 1.

FIG. 3 is a top plan view of a showerhead tile that is an alternate embodiment of the showerhead tile of FIG. 1.

FIG. 4 is a top plan view of a tiled showerhead that is an alternate embodiment of the tiled showerhead of FIG. 2, formed by an array of the showerhead tile of FIG. 3.

FIG. 5 is a top plan view of a showerhead tile that is an alternate embodiment of the showerhead tiles of FIGS. 1 and 3.

FIG. 6 is a top plan view of an array of showerhead tiles formed by the showerhead tiles of FIG. 5.

FIG. 7 is a top plan view of a tiled showerhead that is an alternate embodiment of the tiled showerheads of FIGS. 2 and 4, using arrays shown in FIG. 6.

FIG. 8 is a top plan view of a tiled showerhead that is an alternate embodiment of the tiled showerheads of FIGS. 2, 4 and 7, using the arrays shown in FIG. 6.

FIG. 9 is a perspective view of a showerhead fixture, including a showerhead assembly and a gas distribution conduit, suitable for using the tiled showerheads of FIG. 2, 4, 7 or 8.

3

FIG. 10 is a perspective view of an entry or exit port of a showerhead reactor, suitable for using the showerhead fixture of FIG. 9.

FIG. 11 is a perspective view of an entry and exit ports of two adjoining modular showerhead reactors.

FIG. 12 is a top plan view of semiconductor substrates being processed in series in a modular showerhead reactor.

FIG. 13 is a top plan view of semiconductor substrates being processed in parallel in a showerhead reactor of the kind shown in FIG. 10.

FIG. 14 is a top plan view of groups of semiconductor substrates being processed in parallel in a showerhead reactor of the kind shown in FIG. 10.

FIGS. 15A-15G are examples of arrays of showerhead tiles of the kind shown in FIGS. 1, 3, 5 and 6.

DETAILED DESCRIPTION

With reference to FIGS. 1-9, showerhead tiles, tiled showerheads and a showerhead fixture in accordance with the present invention are shown. The tiled showerhead has an array of showerhead tiles in a modular areawise arrangement. A tiled showerhead is suitable for use in simultaneously processing multiple semiconductor wafers in the showerhead reactors of FIGS. 10 and 11, thereby improving wafer processing throughput as compared to a single-wafer showerhead reactor. Examples of semiconductor wafers or other substrates being processed in a showerhead reactor are shown in FIGS. 12-14. Examples of further arrays of the tiled showerheads are shown in FIGS. 15A-15G.

A tiled showerhead can process multiple substrates in a variety of showerhead reactors. A single fixture having a tiled showerhead can be used in a single-chamber showerhead reactor, to process multiple substrates in one or a series of processing actions in the chamber. Multiple tiled showerheads can be used in a long, linear showerhead reactor having multiple reaction chambers, each chamber having a respective tiled showerhead, to process multiple substrates in parallel in each chamber and in series in successive chambers. A modular showerhead reactor, using modular reactors each having one or more chambers with respective tiled showerheads, can be assembled to process multiple substrates in parallel in each chamber and in series in successive chambers. Respective chambers have physical walls, gas isolation walls and/or exhaust zones in various combinations surrounding the chamber and/or separating the chamber from an adjacent chamber.

The showerhead tiles 100, 300 and 500 shown in FIGS. 1, 3 and 5 respectively are square and have a square central area with a plurality of process gas apertures. Such square showerhead tiles are suitable for processing square semiconductor wafers, such as used in certain types of photovoltaic solar cells, and suitable for processing round semiconductor wafers of a diameter less than or approximately equal to the length of a side of the square central area with the process gas apertures. Other shapes of showerhead tiles and various regions on the tile, such as hexagonal, rectangular, polygonal or round, may be devised by a person skilled in the art. Tiles are connected by welding and so a slight amount of tile border area is provided for a weld bead. Alternative connections can be used, such as bolting. In this regard, each tile can be surrounded by flanges for connection or for cooling or for exhaust.

With reference to FIG. 1, the showerhead tile 100 has a square central area 2, with a plurality of process gas apertures 4, surrounded by a square ring region 6. The square ring region 6 includes two fluid passageways 8 and 10, which are

4

adjacent to the central area 2 of the showerhead tile 100. The square ring region 6 is surrounded by an exhaust region 12, which has a plurality of exhaust apertures 14 and is in the shape of a further square ring. The exhaust region 12 includes a contiguous exhaust slot, a plurality of connected exhaust slots or a plurality of holes of various shapes or sizes as may readily be devised. A flange 16 in the shape of a still further square ring surrounds the exhaust region 12. From the central area 2 outward, the showerhead tile 100 thus has concentric regions for process gas apertures 4, fluid passage, exhaust apertures 14 and a flange 16.

The fluid passageways 8 and 10 are used for two differing purposes in embodiments of the showerhead tile 100, namely cooling in first and third embodiments and provision of a gas curtain in second and third embodiments. In a first embodiment, the two fluid passageways 8 and 10 are connectable to circulate a cooling fluid, which cools the showerhead tile 100.

In a second embodiment, the two fluid passageways 8 and 10 are connectable to a gas supply and provide an isolation gas curtain through gas curtain apertures 20 of the showerhead tile 100. The gas curtain apertures 20 are fluidly connected to the two fluid passageways 8 and 10. Hydrogen is suitable as a gas for the gas curtain. In a further example, nitrogen is suitable as a gas for the gas curtain. Further gases suitable for the gas curtain can be devised.

In a third embodiment, each of the two fluid passageways 8 and 10 acts as a cooling plenum and is open on the surface of the showerhead tile 100 facing a wafer being processed. Hydrogen or other gas passing through the fluid passageways 8 and 10 cools the showerhead tile 100 through heat transfer from the showerhead tile 100 to the gas in the cooling plenum. The hydrogen or other gas proceeds outward from the cooling plenum to form a gas curtain. Each of the two fluid passageways 8 and 10 thus provides a gas curtain and a cooling to the showerhead tile 100.

With reference to FIG. 2, a tiled showerhead 200 has a three by three array 28 of the showerhead tile 100 of FIG. 1. A flange 30 in the shape of a square ring surrounds the array 28 of showerhead tiles 100. The tiled showerhead 200 can be used to process a number of semiconductor wafers equal to the number of showerhead tiles in the array of showerhead tiles. In this example, as there are nine showerhead tiles 100, the tiled showerhead 200 can process nine semiconductor wafers simultaneously e.g. in a three by three array of wafers, in a suitable showerhead reactor.

With reference to FIGS. 3 and 4, a more compact tiled showerhead 400 can be devised by moving the exhaust apertures from the showerhead tiles to the tiled showerhead 400. In FIG. 3, the showerhead tile 300 has a square central area 32 with a plurality of process gas apertures 34. The square central area 32 is surrounded by a square ring region 36 that includes two fluid passageways 38 and 40 adjacent to the central area 32 of the showerhead tile 300. The showerhead tile 300 lacks the exhaust region of the showerhead tile 100 and is thus more compact than the showerhead tile 100. In first, second and third variations of the showerhead tile 300, the fluid passageways 38 and 40 perform similar functions and are configured similarly to the fluid passageways 8 and 10 of the showerhead tile 100.

In FIG. 4, the tiled showerhead 400 has a three by three array 48 of the showerhead tile 300 of FIG. 3. A gas curtain region 42, in the shape of a square ring, surrounds the array 48 of showerhead tiles 300 and has a plurality of gas curtain apertures 50. An exhaust region 52, in the shape of a further square ring and with a plurality of exhaust apertures 54, surrounds the gas curtain region 42 and the array 48 of showerhead tiles 300. In variations, the exhaust region 52 includes

5

a contiguous exhaust slot, a plurality of connected exhaust slots or a plurality of holes of various shapes or sizes as may readily be devised. A flange **56**, in the shape of a still further square ring, surrounds the exhaust region **52**. As a result of using the more compact showerhead tile **300** as compared with the showerhead tile **100**, the tiled showerhead **400** is more compact than the tiled showerhead **200**.

A three by three array of wafers being processed using the tiled showerhead **400** can be more compact than a three by three array of wafers being processed using the tiled showerhead **200**. A showerhead reactor using the tiled showerhead **400** can be more compact than a showerhead reactor using the tiled showerhead **200**.

With reference to FIGS. **5-8**, further variations of tiled shower heads such as the tiled showerhead **700** and the tiled showerhead **800** can be devised by grouping showerhead tiles. In FIG. **5**, the showerhead tile **500** has a plurality of process gas apertures **62**. As depicted, the showerhead tile **500** lacks gas curtain apertures or exhaust apertures and is thus more compact than showerhead tiles having gas curtain apertures and/or exhaust apertures. Further variations of tiled shower heads having grouped showerhead tiles can be devised using showerhead tiles having gas curtain apertures, exhaust apertures or both.

In FIG. **6**, a two by two array **600** of showerhead tiles **500** is formed as a grouping of showerhead tiles. In the tiled showerheads **700** and **800** in FIGS. **7** and **8**, the array **600** of showerhead tiles **500** is repeated in a two by two array of arrays **600** of showerhead tiles **500**. Various further arrays of arrays, arrays of groupings, groupings of arrays, groupings of groupings and so on can be devised by a person skilled in the art. An array **600** of showerhead tiles **500** can be surrounded by a combination of perimeter exhaust regions **72** and inter-array exhaust regions **74** as shown in FIG. **7**, or all of the arrays **600** of showerhead tiles **500** can be surrounded by a perimeter exhaust region **82**. In various examples, exhaust regions employ a plurality of exhaust apertures, a single opening or slot, multiple interconnected openings or slots or other combinations for exhausting as may be devised by a person skilled in the art. In variations, gas isolation regions can be added surrounding the arrays **600**, between the arrays or both. Gas isolation regions can be between a portion of an exhaust region and at least one of the gas curtain apertures, such as between the exhaust region and one of the showerhead tiles, between groups of showerhead tiles, between a group of showerhead tiles and a portion of an exhaust region and so on. A flange **76**, **84** or other region can surround the exhaust region in various examples.

With reference to FIG. **9**, a gas conduit **904** with multiple branches **906** provides gas flow to a showerhead assembly **902** in a showerhead fixture **900**. The showerhead assembly **902** includes one or more plenums **908** and **910**, and one or more diffuser plates **912**, as well as a showerhead plate **914**. The showerhead assembly **902** can use a conventional showerhead or can use one of the tiled showerheads of FIG. **2**, **4**, **7** or **8**. Each branch **906** of the gas conduit **904** provides a gas flow to a respective showerhead tile or group of showerhead tiles. Conduits for a gas isolation curtain and/or an exhaust are readily devised in accordance with the disclosure. In variations, each showerhead tile or each group of showerhead tiles has a respective gas distribution line or multiple gas distribution lines.

Variations of the showerhead assembly **902** are dimensioned and equipped according to the number and arrangement of showerhead tiles in the array of tiles. The plenum or plenums should be large enough for an even distribution of gases. A larger showerhead for a larger array of showerhead

6

tiles should have a taller plenum, more plenums and/or more diffuser plates. Conversely, a smaller showerhead for a lesser number of showerhead tiles in a smaller array of showerhead tiles may have a shorter plenum, fewer plenums and/or fewer diffuser plates.

With reference to FIG. **10**, a showerhead reactor **1000** can be used for simultaneously processing multiple semiconductor wafers or other substrates, by employing one or more of the tiled showerhead **200**, **400**, **700**, **800** or variation thereof in each of one or more reaction chambers. One or more reaction or processing chambers, isolation zones, transit zones and/or other regions or zones are enclosed by the reactor walls **1002**, reactor floor **1014** and reactor lid **1004**. A roller assembly **1008** or other transport mechanism moves wafers or other substrates, which may be on a wafer or substrate carrier, through the showerhead reactor **1000**. Heating units **1006**, such as infrared lamps, electrical resistive heaters, inductive heating units or other heat sources as may be devised, can heat the wafers or other substrates.

Each of the showerhead tiles **100**, **300** or **500** in a tiled showerhead **200**, **400**, **700** or **800** or variation thereof distributes process gas to a respective wafer in the showerhead reactor **1000**. In variations, a gas curtain is provided by the second or the third variation of the showerhead tile **100** as in the tiled showerhead **200**, or by the tiled showerhead **400** or examples of the tiled showerhead **700** or **800**. Exhaust is provided by each of the showerhead tiles **100** in the tiled showerhead **200** or by the tiled showerhead **400**, **700** or **800**.

With reference to FIG. **11**, a semiconductor wafer **1106** or other substrate can be processed in a first showerhead reactor **1102** and subsequently processed in a second showerhead reactor **1104**. The wafer **1106** can be moved in a forward direction **1108** and transferred out of an exit **1118** of the first showerhead reactor **1102**, then transferred into an entrance **1120** of a second showerhead reactor **1104**.

In a modular showerhead reactor, the first showerhead reactor **1102** is a showerhead reactor module and the second showerhead reactor **1104** is a further showerhead reactor module, which can be the of the same or of differing construction and characteristics. In one embodiment of a modular showerhead reactor, the first and second showerhead reactors **1102**, **1104** are modules and are moved in directions **1110**, **1112** toward each other. The exit face **1114** of the first showerhead reactor **1102** is fastened to the entrance face **1116** of the second showerhead reactor **1104** with appropriate hardware and sealing. A substrate can pass directly from the first showerhead reactor **1102** to the second showerhead reactor **1104**.

With reference to FIGS. **12-14**, various parallel and series processing arrangements are shown for processing one or more semiconductor wafers or other substrates in a showerhead reactor. In FIG. **12**, wafers **1202**, **1204** and **1206** or other substrates are processed in series in the showerhead reactor **1000** or variation thereof. Each processing region **1210**, **1212**, **1214** is surrounded by a protection zone as provided by a perimeter protection zone **1216** and an inter-substrate protection zone **1218** or an individual perimeter protection zone **1220**, with each protection zone providing a gas isolation curtain, an exhaust or both. Each wafer **1202** moves in a forward direction **1224** from one processing region **1210** to another processing region **1212** along a path **1222** from an entrance of the reactor to an exit of the reactor.

In FIG. **13**, two wafers **1302** and **1304** or other substrates are processed and move in a forward direction **1308**, **1310** in parallel along a path **1306** through the showerhead reactor

1000 or variation thereof. Dimensions of the reactor and dimensions or arrangements of showerheads are formed accordingly.

In FIG. 14, a plurality of wafers 1402 or other substrates are processed and move in a forward direction 1408 in parallel along a path 1410 through the showerhead reactor 1000 or variation thereof, dimensioned accordingly. The plurality of wafers 1402 is shown as an array of tiles, grouped such that the array of showerhead tiles is an array of groups of showerhead tiles. A group 1406 of wafers is an array of four groups 1404 of wafers. Each group 1404 has four wafers 1402. Each of the sixteen wafers 1402 in the group 1406 is associated with a respective one of the showerhead tiles 500 in a tiled showerhead 700 or 800, for processing when the wafers are positioned under the tiled showerhead 700 or 800 inside of a showerhead reactor 1000. As an example, after the sixteen wafers 1402 in the group 1406 are processed in a reaction or processing zone under a tiled showerhead 700 or 800, the wafers are moved to a subsequent reaction or processing zone and further processed under another tiled showerhead applying similar or differing gases and conditions.

With reference to FIGS. 15A-15G, further embodiments of the tiled showerhead 200, 400, 700 or 800 use various arrays of various shapes of showerhead tiles. FIG. 15A shows a two by two square array 160 of square shapes 162. FIG. 15B shows a four by four square array 164 of square shapes 166. FIG. 15C shows a one by four or a four by one rectangular array 168 of square shapes 170. A rectangular array of width equal to one is also known as a linear array. FIG. 15D shows a two by four or a four by two rectangular array 172 of square shapes 174. FIG. 15E shows a triangular array 176 of circular shapes 178, which has one hundred and twenty degree rotational symmetry. FIG. 15F shows a hexagonal or honeycomb array 180 of circular shapes 182, which has sixty degree, one hundred and twenty degree and one hundred and eighty degree rotational symmetry. FIG. 15G shows a hexagonal or honeycomb array 184 of hexagonal shapes 186, which has one hundred and twenty degree rotational symmetry. Square arrays have ninety degree and one hundred and eighty degree rotational symmetry. Further arrays are readily devised. Showerhead tiles may be arrayed with or without spaces between the tiles or groups of tiles and with or without flanges.

Referring again to FIGS. 1-9 depicting showerhead tiles, tiled showerheads and a tiled showerhead fixture, FIGS. 10-11 depicting showerhead reactors, FIGS. 12-14 depicting substrates being processed in parallel and/or series and FIGS. 15A-15G depicting arrays for tiling showerhead tiles, a full range of variations and combinations of tiled showerheads and single-chamber, multiple-chamber, linear and modular showerhead reactors can be appreciated. A tiled showerhead processes wafers or other substrates side-by-side in parallel. Successive processing can be applied under the same showerhead in the same chamber and/or under a further showerhead in a further chamber.

In a long, linear reactor, whether designed as a single reactor or a modular reactor having multiple modules, a series of showerheads is placed along the length of the reactor in one or more chambers. Each chamber is widened to process wafers side-by-side, as is any passageway from one chamber to another. Each tiled showerhead directs processing gas to the respective substrates. Exhaust channels or ports direct exhaust gas flows from substrates. Gas isolation curtains can be provided by gas flows emanating from tiled showerheads so equipped with gas isolation apertures. A lid of the reactor can be integrated with gas conduits, can be integrated with showerhead fixtures, or can be separate from such.

A standard, single-wafer showerhead reactor is usually of a cold-wall or hot-wall type. A cold-wall reactor has walls that are not expressly heated, and can experience a condensation of particles on the cold walls from reactions of the various process gases. A hot-wall reactor has walls that are expressly heated, and can experience reactions on the heated walls.

In contrast, a "zero" or no wall reactor has a chamber with no physical walls, and has instead walls that are created by gas flows such as gas isolation curtains. The "zero" wall reactor has many or all of the benefits of cold-wall and hot-wall reactors with fewer or none of the drawbacks of either. Physical walls outside of the isolation zones prevent contamination from the atmosphere, i.e. gases arriving from outside of a deposition zone, and allow overall pressure control. Thus, the "zero" wall reactor does have physical walls, but the reaction or deposition chamber within the reactor is defined by isolation zones having gas isolation curtains or other gas flows. Exhaust zones pull gases away from substrates, so that contaminants such as arsenic or other processing leftovers or byproducts are not passed along to other wafers outside of a processing zone. Pressure balancing is applied among process gas flows, exhaust gas flows and gas isolation curtain flows. Examples of tiled showerheads having provision for an exhaust gas flow and/or a gas isolation curtain flow can be used in a "zero" wall showerhead reactor.

Isolation zones with gas curtain "walls" allow a mechanically simpler apparatus that does not have mechanical doors opening and closing when a substrate is moved from one processing zone to another processing zone, although mechanical doors or the like could be used. As an example, a deposition e.g. an epitaxial deposition can be applied in a first zone, with a further deposition applied in a second zone, followed by cleaning in the second or in a third zone, and further followed by etching in a fourth or subsequent zone, with processing zones separated by isolation zones. A "train" of substrate carriers can proceed one after the other, with substrates being processed in parallel in each processing zone, and substrates being processed in series in subsequent processing zones and subsequent modules.

By combining parallel processing of a group or an array of substrates under a tiled showerhead and serial processing through subsequent processing zones or modules having one or more further tiled showerheads, throughput of substrates is greatly increased as compared to a single-substrate showerhead reactor or as compared to a series processing single-substrate-wide showerhead reactor. Multiple examples of a long, linear showerhead reactor or of a modular showerhead reactor including multiple modules, each of which uses one or more tiled showerheads, can be arrayed horizontally or vertically or both for further improvements in substrate processing throughput.

One of the advantages of a modular showerhead is that very large substrates may be processed at a single time. For example, large area P-N junctions can be formed, then diced into smaller pieces, or used as a large panel. A modular showerhead formed by groups of array of tiles would be appropriate to processing large substrates.

What is claimed is:

1. A showerhead for a semiconductor-processing reactor, comprising:

an array of showerhead tiles, with each showerhead tile having a plurality of process gas apertures in a central area of the showerhead tile and a border, the border of each tile in contact with and connected to a border of at least one other tile, each showerhead tile of the array being dimensioned for processing a substrate; and

9

an exhaust region surrounding the process gas apertures and including a surface extending from one or more central areas of one or more of the showerhead tiles, the exhaust region having at least one exhaust aperture in the surface.

2. The showerhead of claim 1 wherein the exhaust region surrounds the array of showerhead tiles.

3. The showerhead of claim 1 wherein the exhaust region is a part of each showerhead tile and surrounds the process gas apertures of each showerhead tile.

4. The showerhead of claim 1 wherein the showerhead tiles are grouped in a plurality of arrays with each array having an exhaust region.

5. The showerhead of claim 1 wherein the at least one exhaust aperture includes a plurality of exhaust apertures.

6. The showerhead of claim 1 wherein each showerhead tile is square.

7. The showerhead of claim 1 wherein each showerhead tile is circular, rectangular or polygonal.

8. The showerhead of claim 1 wherein each showerhead tile has at least one gas curtain aperture between the exhaust region and the plurality of process gas apertures.

9. The showerhead of claim 1 wherein each showerhead tile includes at least one gas curtain aperture.

10. The showerhead of claim 1 wherein the array of showerhead tiles is a square array.

11. The showerhead of claim 1 wherein the array of showerhead tiles is a rectangular array.

12. The showerhead of claim 1 wherein the array of showerhead tiles has a rotational symmetry.

13. A showerhead for a semiconductor-processing reactor, comprising:

an array of showerhead tiles, each showerhead tile having a border and a plurality of process gas apertures in a central area of the showerhead tile with at least one fluid passageway adjacent to the central area of the showerhead tile, the border of each tile in contact with and connected to a border of at least one other tile, each showerhead tile of the array being dimensioned for processing a substrate; and

a plurality of exhaust regions, each exhaust region surrounding the central area of each showerhead tile, each exhaust region including a surface extending from the

10

central area of each showerhead tile, and each exhaust region having at least one exhaust aperture in the surface.

14. The showerhead of claim 13 wherein, on each showerhead tile, the at least one fluid passageway includes two cooling passageways.

15. The showerhead of claim 13 wherein, on each showerhead tile, the at least one fluid passageway includes two gas passageways fluidly connected to gas curtain apertures.

16. The showerhead of claim 13 wherein, on each showerhead tile, the at least one fluid passageway is between a portion of the central area and a portion of the exhaust region.

17. A showerhead for a semiconductor-processing reactor, comprising:

an array of showerhead tiles, each showerhead tile having a border, a plurality of process gas apertures in a central area of the showerhead tile and at least one fluid passageway adjacent to the central area of the showerhead tile, the border of each showerhead tile in contact with and connected to a border of at least one other showerhead tile, each showerhead tile of the array being dimensioned for processing a substrate; and

an exhaust region surrounding the array of showerhead tiles and including a surface extending from the central areas of the showerhead tiles, the exhaust region having at least one exhaust aperture in the surface.

18. The showerhead of claim 17 wherein, on each showerhead tile, the at least one fluid passageway includes two cooling plenums.

19. The showerhead of claim 17 wherein, on each showerhead tile, the at least one fluid passageway includes two gas passageways fluidly connected to gas curtain apertures.

20. The showerhead of claim 17 further including a gas curtain region surrounding the array of showerhead tiles and having a plurality of gas curtain apertures, wherein the exhaust region surrounds the gas curtain region.

21. The showerhead of claim 1 further comprising a flange surrounding the exhaust region and having a surface extending from the exhaust region surface.

* * * * *